# IEC 60384-4

(Fourth edition – 2007)

Fixed capacitors for use in electronic equipment – Part 4: Sectional specification – Aluminium electrolytic capacitors with solid (MnO<sub>2</sub>) and nonsolid electrolyte

# CORRIGENDUM 1

Page 31

Replace, in Table 7, under the title of the first column, the unit "g" by "m/s<sup>2</sup>".

June 2007

# INTERNATIONAL STANDARD



QC 300300

Fourth edition 2007-03

Fixed capacitors for use in electronic equipment –

Part 4: Sectional specification – Aluminium electrolytic capacitors with solid (MnO<sub>2</sub>) and non-solid electrolyte



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# INTERNATIONAL ELECTROTECHNICAL COMMISSION

# FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT -

# Part 4: Sectional specification – Aluminium electrolytic capacitors with solid (MnO<sub>2</sub>) and non-solid electrolyte

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International Standard IEC 60384-4 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This fourth edition cancels and replaces the third edition published in 1998 and its amendment 1 (2000). This edition constitutes a minor revision related to tables, figures and references.

The text of this standard is based on the following documents:

CDV	Report on voting
40/1759/CDV	40/1819/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The QC number that appears on the front cover of this publication is the specification number in the IEC Quality Assessment System for Electronic Components (IECQ).

The list of all parts of the IEC 60384 series, under the general title *Fixed capacitors for use in electronic equipment*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

# FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

# Part 4: Sectional specification – Aluminium electrolytic capacitors with solid (MnO<sub>2</sub>) and non-solid electrolyte

# 1 General

# 1.1 Scope

This part of IEC 60384 applies to aluminium electrolytic capacitors with solid  $(MnO_2)$  and nonsolid electrolyte primarily intended for d.c. applications for use in electronic equipment. It covers capacitors for long-life applications and capacitors for general-purpose applications.

Capacitors for special-purpose applications may need additional requirements.

Capacitors for fixed surface mount aluminium electrolytic capacitors are not included but they are covered by IEC 60384-18.

# 1.2 Object

The principal object of this standard is to prescribe preferred ratings and characteristics and to select from IEC 60384-1 the appropriate quality assessment procedures, tests and measuring methods and to give general performance requirements for this type of capacitor. Test severities and requirements prescribed in detail specifications referring to this sectional specification shall be of equal or higher performance level, because lower performance levels are not permitted.

#### 1.3 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60063, Preferred number series for resistors and capacitors

IEC 60068-1, Environmental testing – Part 1: General and guidance

IEC 60068-2-17, Environmental testing – Part 2-17: Tests – Test Q: Sealing

IEC 60068-2-54, Environmental testing – Part 2-54: Tests – Test Ta: Solderability testing of electronic components by the wetting balance method

IEC 60384-1:1999, Fixed capacitors for use in electronic equipment – Part 1: Generic specification

IEC 60384-4-1, Fixed capacitors for use in electronic equipment – Part 4-1: Blank detail specification – Fixed aluminium electrolyte capacitors with non-solid electrolyte – Assessment level EZ

IEC 60384-4-2, Fixed capacitors for use in electronic equipment – Part 4-2: Blank detail specification – Fixed aluminium electrolyte capacitors with solid (MnO2) electrolyte – Assessment level EZ

ISO 3, Preferred numbers – Series of preferred numbers

#### 1.4 Information to be given in a detail specification

Detail specifications shall be derived from the relevant blank detail specification.

Detail specifications shall not specify requirements inferior to those of the generic, sectional or blank detail specification. When more severe requirements are included, they shall be listed in 1.9 of the detail specification and indicated in the test schedules, for example, by an asterisk.

NOTE The information given in 1.4.1 may, for convenience, be presented in tabular form.

The following information shall be given in each detail specification and the values quoted shall preferably be selected from those given in the appropriate clause of this sectional specification.

#### 1.4.1 Outline drawing and dimensions

There shall be an illustration of the capacitor as an aid to easy recognition and for comparison of the capacitor with others.

Dimensions and their associated tolerances, which affect interchangeability and mounting, shall be given in the detail specification. All dimensions shall preferably be stated in millimeters; however, when the original dimensions are given in inches, the converted metric dimensions in millimetres shall be added.

Normally, the numerical values shall be given for the length of the body, the width and height of the body and the wire spacing, or for cylindrical types, the body diameter, and the length and diameter of the terminations. When necessary, for example, when a number of items (capacitance values/voltage ranges) are covered by a detail specification, the dimensions and their associated tolerances shall be placed in a table below the drawing.

When the configuration is other than described above, the detail specification shall state such dimensional information as will adequately describe the capacitor. When the capacitor is not designed for use on printed boards, this shall be clearly stated in the detail specification.

#### 1.4.2 Mounting

The detail specification shall specify the method of mounting to be applied for normal use and for the application of the vibration and the bump or shock tests. The capacitors shall be mounted by their normal means. The design of the capacitor may be such that special mounting fixtures are required in its use. In this case, the detail specification shall describe the mounting fixtures and they shall be used in the application of the vibration and bump or shock tests.

#### 1.4.3 Ratings and characteristics

The ratings and characteristics shall be in accordance with the relevant clauses of this specification, together with the following.

#### 1.4.3.1 Rated capacitance range

See 2.2.1.

NOTE When products approved to the detail specification have different ranges, the following statement should be added: "The range of values available in each voltage range is given in IEC QC 001005.".

# 1.4.3.2 Particular characteristics

Additional characteristics may be listed when they are considered necessary to specify adequately the component for design and application purposes.

# 1.4.3.3 Soldering

The detail specification shall prescribe the test methods, severities and requirements applicable for the solderability and the resistance to soldering heat test.

# 1.4.4 Marking

The detail specification shall specify the content of the marking on the capacitor and on the package. Deviations in 1.6 of this sectional specification shall be specifically stated.

# 1.5 Terms and definitions

For the purposes of this document, the following terms and definitions, in addition to the applicable terms and definitions of IEC 60384-1, apply.

# 1.5.1

# capacitance of an electrolytic capacitor

capacitance of an equivalent circuit having capacitance and resistance in series measured with alternating current approximately sinusoidal waveform at a specified frequency

# 1.5.2

# long-life grade capacitors

capacitors intended for applications where a high degree of stability of characteristics over a long life is essential. The materials are chosen and the manufacture carried out so that improved performance is obtained with consequent increase in life

#### 1.5.3

#### general-purpose grade capacitors

capacitors intended for applications where the high performance level of long-life grade capacitors is not required

# 1.5.4

reverse voltage (for polar capacitors only)

voltage applied to the capacitor terminals in the reverse polarity direction

# 1.6 Marking

According to 2.4 of IEC 60384-1, with the following details.

**1.6.1** The information given in the marking is normally selected from the following list; the relative importance of each item is indicated by its position in the list:

- a) rated capacitance;
- b) rated voltage (d.c. voltage may be indicated by the symbol: \_\_\_\_\_ or \_\_\_\_);
- c) category voltage and category temperatures (for long-life grade capacitors only);
- d) polarity of the terminations: for multi-section capacitors, the rated capacitance and rated voltage of the sections connected to each termination shall be shown in an unambiguous way. The termination of a capacitor section which is intended for direct connection to the rectifier (so-called reservoir section) shall be marked with the number 1 or with the colour red;
- e) tolerance on rated capacitance;

- f) reference to the grade (for long-life grade capacitors only). The abbreviation LL may be used for marking purposes;
- g) year and month (or week) of manufacture;
- h) manufacturer's name or trade mark;
- i) climatic category;
- j) manufacturer's type designation;
- k) reference to the detail specification.

**1.6.2** The capacitor shall be clearly marked with a), b), c), d), e) and f) above with as many as possible of the remaining items as is considered necessary. Any duplication of information in the marking on the capacitor should be avoided.

**1.6.3** The package containing the capacitor(s) shall be clearly marked with all the information listed in 1.6.1.

**1.6.4** Any additional marking shall be so applied that no confusion can arise.

### 2 Preferred ratings and characteristics

#### 2.1 Preferred characteristics

The values given in detail specifications shall preferably be selected from the following.

#### 2.1.1 Preferred climatic categories

The capacitors covered by this specification are classified into climatic categories according to the general rules given in IEC 60068-1.

The lower and upper category temperature and the duration of the damp-heat steady-state test shall be chosen from the following.

Lower category temperature:	–55 °C, –40 °C, –25 °C and –10 °C
Upper category temperature:	+85 °C, +100 °C, +105 °C and +125 °C
Duration of the damp-heat steady-state test:	10, 21 and 56 days

The severities for the cold and dry heat tests are the lower and upper category temperatures respectively.

#### 2.2 Preferred values of ratings

#### 2.2.1 Rated capacitance (C<sub>R</sub>)

Preferred values of rated capacitance are chosen from the E3 series of IEC 60063 and their decimal multiples.

If other values are needed, they shall preferably be chosen from the E6 series.

# 2.2.2 Tolerance on rated capacitance

Preferred values of tolerances on rated capacitance are:

-10/+10 %	-10/+75 %
-10/+30 %	-10/+100 %
-10/+50 %	-20/+20 %

# 2.2.3 Rated voltage ( $U_R$ )

Preferred values of rated direct voltages taken from the R5 and R10 series of ISO 3 are:

For voltage values <250 V:</th>1 V, 1,6 V, 2,5 V, 4 V, 6,3 V and their decimal<br/>multiples (R5 series), also 35 V, 50 V, 80 V and<br/>200 V;For voltage values  $\geq 250 V$ :250 V, 315 V, 350 V, 400 V, 450 V and 500 V<br/>(250 V, 315 V, 400 V and 500 V are in accordance<br/>with the R10 series; 350 V and 450 V are permitted<br/>in addition).

# 2.2.4 Category voltage ( $U_{\rm C}$ )

The category voltage is equal to the rated voltage, unless otherwise stated in the detail specification.

#### 2.2.5 Ripple voltage

An alternating voltage may be applied provided that the peak voltage resulting from the alternating voltage superimposed on the direct voltage does not exceed the value of rated direct voltage and that the rated ripple current (see 2.2.8) and the permissible reverse voltage (see detail specification) are not exceeded.

#### 2.2.6 Reverse voltage

The permissible reverse voltage shall be given in the detail specification.

# 2.2.7 Surge voltage ratio

The surge voltage shall be 1,15 times the rated or category voltage for rated voltages  $\leq$ 315 V or 1,10 times the rated or category voltage for rated voltages >315 V.

See also 4.14.

# 2.2.8 Rated ripple current

The rated ripple current at 100 Hz or 120 Hz and at upper category temperature shall be given in the detail specification. Alternatively, for capacitors for switched mode power supply application, the rated ripple current shall be stated at the relevant frequency.

NOTE This value is determined by the dimensions of the capacitor and several other factors, for example, the tangent of loss angle and the permissible temperature rise.

See also 2.2.5.

# 3 Quality assessment procedures

#### 3.1 Primary stage of manufacture

For capacitors with solid electrolyte, the primary stage of manufacture is the etching or formation of the anode body.

For capacitors with non-solid electrolyte, the primary stage of manufacture is the capacitor manufacturer's evaluation of the formed anode foil.

#### 3.2 Structurally similar components

Capacitors considered as being structurally similar are capacitors produced with similar processes and materials, though they may be of different case sizes and values.

#### 3.3 Certified records of released lots

The information required in 3.9 of IEC 60384-1 shall be made available when prescribed in the detail specification and when requested by a purchaser. After the endurance test the parameters for which variables information is required are the capacitance change, tan  $\delta$  and the leakage current.

# 3.4 Qualification approval procedures

The procedures for qualification approval testing are given in 3.5 of IEC 60384-1.

The schedule to be used for qualification approval testing on the basis of lot-by-lot and periodic tests is given in 3.5 of this specification. The procedure using a fixed sample size schedule is given in 3.4.1 and 3.4.2 below.

#### 3.4.1 Qualification approval on the basis of the fixed sample size procedure

#### Sampling

The fixed sample size procedure is described in 3.5.3b) of IEC 60384-1. The sample shall be representative of the range of capacitors for which approval is sought. This may or may not be the complete range covered by the detail specification.

The sample shall consist of specimens having the lowest and highest voltages and, for these voltages, the smallest and largest case size. When the range of rated voltages exceeds 200 V, an intermediate voltage shall also be tested. In each of these case size/voltage combinations (values), the highest capacitance shall be chosen. Thus, for the approval of a range, testing is required of either four or six values. When the range consists of less than four values, the number of specimens to be tested shall be that required for four values.

Spare specimens are permitted as follows.

- a) One per value which may be used to replace the permitted defective in Group 0.
- b) One per value which may be used as replacements for specimens which are defective because of incidents not attributable to the manufacturer.

The numbers given in Group 0 assume that all groups are applicable. If this is not so, the numbers may be reduced accordingly.

When additional groups are introduced into the qualification approval test schedule, the number of specimens required for Group 0 shall be increased by the same number as that required for the additional groups.

Table 1 gives the number of samples to be tested in each group or subgroup together with the permissible number of nonconforming items for qualification approval tests.

# 3.4.2 Tests

The complete series of tests specified in Tables 1 and 2 are required for the approval of capacitors covered by one detail specification. The tests of each group shall be carried out in the order given.

The whole sample shall be subjected to the tests of Group 0 and then divided for the other groups.

Specimens found to be a nonconforming item during the tests of Group 0 shall not be used for the other groups.

"One nonconforming item" is counted when a capacitor has not satisfied the whole or part of the tests of a group.

Approval is granted when the number of nonconforming items does not exceed the specified number of permissible nonconforming items for each group or subgroup and the total number of permissible nonconforming items.

NOTE Tables 1 and 2 together form the fixed sample size test schedule, for which Table 1 includes the details for the sampling and permissible nonconforming items for the different tests or groups of tests, whereas Table 2 together with the details of test contained in Clause 4, gives a complete summary of test conditions and performance requirements and indicates where, for example, for the test method or conditions of test a choice should be made in the detail specification.

The conditions of test and performance requirements for the fixed sample size test schedule should be identical to those prescribed in the detail specification for quality conformance inspection.

Group No.	Test	Subclause of this publication	Number of specimens n <sup>e</sup>	Permissible number of nonconforming items c				
0	High surge current <sup>a</sup>	4.21	120+ 12 <sup>f</sup> + 12 <sup>g</sup>	0				
	Visual examination	4.2						
	Dimensions	4.2						
	Leakage current	4.3.1						
	Capacitance	4.3.2						
	Tangent of loss angle	4.3.3						
	Impedance <sup>b</sup>	4.3.4						
	Spare specimens		12					
1A	Robustness of terminations	4.4	12	0				
	Resistance to soldering heat <sup>c</sup>	4.5						
1B	Solderability <sup>c</sup>	4.6	12	0				
	Rapid change of temperature	4.7						
	Vibration	4.8						
	Bump or shock <sup>b</sup>	4.9 or 4.10						
1	Climatic sequence	4.11	24	0				
2	Damp heat, steady state	4.12	12	0				
3	Endurance	4.13	36	0				
4A	Surge voltage	4.14	12	0				
4B	Reverse voltage <sup>b</sup>	4.15	12 <sup>f</sup>	0				
	Pressure relief <sup>b</sup>	4.16						
5A	Storage at high temperature	4.17	12	0				
	Voltage transient overload <sup>d</sup>	4.22						
5B	Storage at low temperature <sup>b</sup>	4.18	12 <sup>g</sup>	0				
6	Characteristics at high and low temperature	4.19	12	0				
	Charge and discharge <sup>b</sup>	4.20						
а	For solid electrolyte capacitors only and if requi	red in the detail spec	cification.	•				
b	If required in the detail specification.							
С	Not applicable to capacitors with screw terminations or other terminations, not designed to be soldered, as stated in the detail specifications.							
d	For non-solid electrolyte capacitors only and if required in the detail specification.							
е	For case size/voltage combinations, see 3.4.1.							
f	Additional capacitors if Group No. 4B is tested.							
g	Additional capacitors if Group No. 5B is tested.							

# Table 1 – Fixed sample size test plan for qualification approval, assessment level EZ

Subclause number and test <sup>a</sup>		D or ND b	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Performance requirements <sup>a</sup>
Group	0	ND		See Table 1	
4.21	High surge current <sup>c</sup>				
4.2	Visual examination				No visible damage Legible marking and as specified in the detail specification
4.2	Dimensions (detail)				See detail specification
4.3.1	Leakage current		Protective resistance: $\Omega$		As in 4.3.1.2
4.3.2	Capacitance		Frequency: Hz		Within specified tolerance
4.3.3	Tangent of loss angle		Frequency: Hz		As in 4.3.3.2
4.3.4	Impedance (if applicable)		Frequency: Hz		Within limits specified in the detail specification
Group	) 1A	D		See Table 1	
4.4.1	Initial measurement		Capacitance		
4.4	Robustness of terminations		Method and severity as prescribed in the detail specification Visual examination		No visible damage
4.5	Resistance to soldering heat <sup>d</sup>		No pre-drying See detail specification for the method (1A or 1B)		
4.5.2	Final measurements		Visual examination		No visible damage Legible marking
			Capacitance		$\Delta C/C \le 5$ % of value measured in 4.4.1
Group	) 1B	D		See Table 1	
4.6	Solderability <sup>d</sup>		See detail specification for the method		Good tinning as evidenced by free flowing of the solder with wetting of the terminations or meet the required parameter(s) in the detail specification as applicable

# Table 2 – Test schedule for qualification approval

<sup>a</sup> Subclause numbers of test and performance requirements refer to Clause 4.

<sup>b</sup> In this table, D = destructive, ND = non-destructive.

<sup>c</sup> For solid electrolyte capacitors only and if prescribed by the detail specification.

<sup>d</sup> Not applicable to capacitors with screw terminations or other terminations, not designed to be soldered, as stated in the detail specification.

Subclause number and test <sup>a</sup>		D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Performance requirements <sup>a</sup>	
Group	<b>1B</b> (continued)			See Table 1		
4.7	Rapid change of temperature		T <sub>A</sub> = Lower category temperature			
			T <sub>B</sub> = Upper category temperature			
			Five cycles			
			Duration $t_1 = \dots$ min			
			Recovery: 16 h			
4.7.1	Initial measurement	D	Capacitance			
4.7.3	Final measurements		Solid electrolyte:			
			Visual examination		No visible damage	
			Leakage current		As in 4.3.1	
			Tangent of loss angle		As in 4.3.3	
			Impedance (if required)		As specified in the detail specification	
			Non-solid electrolyte:			
			Visual examination		No leakage of electrolyte or other visible damage	
4.8	Vibration		For mounting method, see detail specification			
			Frequency range: from Hz to Hz			
			Amplitude: mm or acceleration 100 m/s <sup>2</sup> (whichever is the less severe)			
			Total duration: h			
4.8.2	Final measurements		Visual examination		No visible damage and for non-solid electrolyte capacitors no leakage of electrolyte Legible marking	
			Capacitance		$\Delta C/C \leq 5$ % of value measured in 4.7.1, unless otherwise prescribed in the detail specification	
4.9	Bump (or shock, see 4.10)		For mounting method, see detail specification			
			Number of bumps:			
			Acceleration: 400 m/s <sup>2</sup>			
			Duration of pulse: 6 ms			
<sup>a</sup> Subclause numbers of test and performance requirements refer to Clause 4.						
<sup>b</sup> In	this table, D = destructiv	/e, ND	= non-destructive.			

Subc	lause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Performance requirements <sup>a</sup>
Group 1	B (continued)			See Table 1	
	hock (or bump, see .9)		For mounting method, see detail specification		
			Acceleration: m/s <sup>2</sup>		
			Duration of pulse: ms		
4.9.2 or F	4.10.2 inal measurements		Visual examination		No visible damage and for non-solid electrolyte capacitors no leakage of electrolyte
			Capacitance		$\Delta C/C \leq 5$ % of values measured in 4.3.2, unless otherwise specified in the detail specification
Group 1		D		See Table 1	
4.11	Climatic sequence				
4.11.1	Dry heat		Temperature: upper category temperature		
			Duration: 16 h		
4.11.2	Damp heat, cyclic, Test Db, first cycle				
4.11.3	Cold	D	Temperature: lower category temperature		
			Duration: 2 h		
4.11.4	Low air pressure (if required by the detail specification)		Air pressure: 8 kPa		
4.11.4.3	Intermediate measurement		Visual examination		No breakdown, flashover or harmful deformation of the case
4.11.5	Damp heat, cyclic, Test Db, remaining cycles				
4.11.6	Sealing (if required by the detail specification)		Method:		
4.11.7	Final measurements		Visual examination		No visible damage and for non-solid electrolyte capacitors no leakage of electrolyte Legible marking
<sup>a</sup> Subo	lause numbers of test	and pe	erformance requirements refe	er to Clause 4.	
<sup>b</sup> In th	is table, D = destructiv	e, ND	= non-destructive.		

Subo	clause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens (n) and number of permissible nonconforming items (c)	Performance requirements <sup>a</sup>
Group '	1 (continued)	D		See Table 1	
4.11.7 (	continued)		Leakage current		As in 4.3.1
			Capacitance		$\Delta C/C$ for:
					<b>Solid electrolyte:</b> Long-life grade: ≤5 % General-purpose grade: ≤10 %
					Non-solid electrolyte: ≤10 % of value measured in 4.5.2, 4.9.2 or 4.10.2 as applicable
			Tangent of loss angle		≤1,2 times limit of 4.3.3
Group	2	D		See Table 1	
4.12	Damp heat, steady state				
4.12.1	Initial measurement		Capacitance		
4.12.2	Final measurements		Visual examination		No visible damage, and for non-solid electrolyte capacitor, no leakage of electrolyte Legible marking
			Leakage current		As in 4.3.1
			Capacitance		$\Delta C/C$ for:
					<b>Solid electrolyte:</b> Long-life grade: ≤5 % General-purpose grade: ≤10 %
					<b>Non-solid electrolyte:</b> Long-life grade: ≤10 %
					General-purpose grade: ≤20 % of value measured in 4.12.1
			Tangent of loss angle		≤1,2 times limit in 4.3.3
			Impedance		≤1,2 times the limit in the detail specification
			Insulation resistance of the external insulation (if applicable)		≥100 MΩ
			Voltage proof of the external insulation (if applicable)		No breakdown or flashover
<sup>a</sup> Sub	clause numbers of test	and pe	erformance requirements re	fer to Clause 4.	
	iis table, D = destructiv				

# Table 2 (continued)

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Subclause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens (n) and number of permissible nonconforming items (c)	Performance requirements <sup>a</sup>		
Group 3	D		See Table 1			
4.13 Endurance		Duration: Long-life grade:: h General-purpose grade:: h Temperature: upper category temperature				
		Applied voltage: V				
		Recovery: 16 h min.				
4.13.1 Initial measurement		Capacitance				
4.13.3 Final measurements		Solid electrolyte capacitors				
		Visual examination		No visible dam Legible markin		
		Leakage current		As in 4.3.1		
		Capacitance		$\Delta C/C \le 10$ % of measured in 4.		
		Tangent of loss angle		≤1,2 times the specified in 4.3		
		Impedance		≤1,2 times the detail specifica		
		Insulation resistance of the external insulation (if applicable)		≥100 MΩ		
		Voltage proof of the external insulation (if applicable)		No breakdown	or flashove	
		Non-solid electrolyte capacitors				
		Visual examination		No leakage of or other visible Legible markin	damage	
		Leakage current		As in 4.3.1		
		Capacitance		$\Delta C/C$ compared measured in 4.		
				Long-life grad	le:	
				Rated voltage (V)	$\Delta C/C$ (%)	
				U <sub>R</sub> ≤6,3	+15 to -30	
				6,3< U <sub>R</sub> ≤ 160	± 20	
				160 < <i>U</i> <sub>R</sub> − 100	± 15	

<sup>b</sup> In this table, D = destructive, ND = non-destructive.

Table 2	(continued)
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Subclause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Perfor require	
Group 3 (continued)			See Table 1		
4.13.3 (continued)		Capacitance		General-purp	-
				Rated voltage (V)	Δ <i>C</i> / <i>C</i> ( %)
				$U_{R} \le 6,3$ 6,3< $U_{R} \le 160$ 160 < $U_{R}$	+25 to -40 ± 30 ± 15
		Tangent of loss angle		Long-life gra ≤ 1,5 times the specified in 4.	e limit 3.3
				General-purp $\leq 2$ times the in 4.3.3 or $\leq 0$ , is the greater	imit specified
		Impedance		Long-life gra ≤2 times the li in the detail sp	mit specified pecification
				General-purp ≤4 times the li detail specific	mit in the
		Insulation resistance of external insulation (if applicable)		≥100 MΩ	
		Voltage proof of external insulation (if applicable)		No breakdowr	n or flashover
Group 4A	D		See Table 1		
4.14 Surge		Number of cycles: 1 000			
		Temperature: °C Charge voltage: 1,15 $U_R$ or 1,15 $U_C$ for $U_R \le 315$ V or 1,10 $U_R$ or 1,10 $U_C$ for $U_R > 315$ V			
		Duration of charge: 30 s Duration of no-load: 5 min 30 s			
<ul><li>4.14.1 Initial measurement</li><li>4.14.3 Final measurements</li></ul>		Capacitance Visual examination (for non-solid electrolyte		No visible dan leakage of ele	
		capacitors)			-
		Leakage current Capacitance		As in 4.3.1 $\Delta C/C$ for	
				Solid electro Long-life grad General-purpo ≤10 % Non-solid ele	e: ≤5 % ose grade: ectrolyte:
				≤15 % of value in 4.14.1	e measured
		Tangent of loss angle		As in 4.3.3	
<ul> <li><sup>a</sup> Subclause numbers of test</li> <li><sup>b</sup> In this table, D = destructive</li> </ul>		formance requirements refer non-destructive.	to Clause 4.		

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Subcl	ause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Performance requirements <sup>a</sup>
Group	4B	D		See Table 1	
4.15	Reverse voltage (if required)		Duration:125 h at upper category temperature with		
			a) for solid electrolyte capacitors: a direct voltage of 0,15 $U_{\rm C}$ in reverse polarity direction or		
			b) for non-solid electrolyte capacitors: voltage 1 V d.c. in reverse polarity direction, unless otherwise specified in the detail specification, followed by 125 h at upper category temperature with category voltage in forward polarity direction		
4.15.1	Initial measurement		Capacitance		
4.15.3	Final measurements		Leakage current		As in 4.3.1
			Capacitance		Δ <i>C/C</i> for <b>Solid electrolyte</b> : ≤10 %
					<i>Non-solid electrolyte</i> : See detail specification, of value measured in 4.15.1
			Tangent of loss angle		As in 4.3.3
4.16	Pressure relief (if required)		Test method:		Device shall open without danger of explosion or fire
Group	5A	ND		See Table 1	
4.17	Storage at high temperature		Temperature: upper category temperature		
			Duration: 96 h $\pm$ 4 h		
			Recovery: 16 h min.		
4.17.1	Initial measurement		Capacitance		
4.17.3	Final measurements		Visual examination		No visible damage and for non-solid electrolyte capacitors no leakage of electrolyte
			Leakage current		<b>Solid electrolyte</b> capacitors: As in 4.3.1
					Non-solid electrolyte capacitors: ≤2 times the limit of 4.4.1
<sup>a</sup> Sub	clause numbers of te	est and p	I erformance requirements refe	er to Clause 4.	1
	nis table, D = destruc				

# Table 2 (continued)

Table 2	2 (con	tinued)
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Subcla	ause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens ( <i>n</i> ) and number of permissible nonconforming items ( <i>c</i> )	Performance requirements <sup>a</sup>
Group 5	5A (continued)			See Table 1	
4.17.3	(continued)				
			Capacitance		$\Delta C/C$ for:
					Solid electrolyte: ≤5 %
					<i>Non-solid electrolyte:</i> ≤10 % of value measured in 4.17.1
			Tangent of loss angle		<b>Solid electrolyte:</b> As in 4.3.3
					<i>Non-solid electrolyte:</i> ≤1,2 times the limit of 4.3.3
4.22	Voltage transient overload <sup>d</sup>		Items in 4.40 of IEC 60384-1 to be specified by the detail specification		
4.22.1	Initial measurement		Capacitance		
4.22.2	Final		Visual examination		See detail specification
	measurements		Capacitance		See detail specification
			Leakage current		See detail specification
			Tangent of loss angle		See detail specification
			Other parameters		See detail specification
Group 5	5B <sup>c</sup>	ND		See Table 1	
4.18	Storage at low temperature (for non-solid electro- lyte capacitors		Duration: 16 h or 4 h after thermal stability has been reached (whichever is the shorter)		
	only)		Temperature: -40 °C		
			Recovery: 16 h min.		
4.18.1	Initial measurement		Capacitance		
4.18.2	Final measurements		Visual examination		No visible damage and no leakage of electrolyte Legible marking
			Leakage current		As in 4.3.1
			Capacitance		$\Delta C/C \le 10$ % of value measured in 4.18.1
			Tangent of loss angle		As in 4.3.3
<sup>a</sup> Subo	clause numbers of te	est and pe	erformance requirements refe	er to Clause 4.	
<sup>b</sup> In th	is table, D = destruc	tive, ND	= non-destructive.		
<sup>c</sup> Grou	up 5B is only applica	ble to ca	pacitors with a lower category	y temperature of -25 °	C and -10 °C.
d Form	non-solid electrolyte	capacito	rs only and if required in the	detail specification.	

Table	2	(continued)	

Subcl	ause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens (n) and number of permissible nonconforming items (c)	Performance requirements <sup>a</sup>
Group	6	D		See Table 1	
4.19	Characteristics at high and low temperature		The capacitors shall be measured at each temperature step		
			Solid electrolyte capacitors: Step 1: 20 °C		
			Capacitance <sup>c</sup>		For use as reference value
			Impedance (at the same frequency as Step 2)		For use as reference value
			Tangent of loss angle <sup>c</sup>		
			<i>Step 2:</i> Lower category temperature		
			Capacitance <sup>c</sup>		$\Delta C/C \leq 20$ % of value measured in Step 1
			Impedance		Ratio with respect to value in Step 1: ≤2 times
			Tangent of loss angle <sup>c</sup>		$\leq$ 2 times the limit of 4.3.3.
			<i>Step 3:</i> Upper category temperature		
			Leakage current		At 125 °C (with $U_R$ ):
					$\leq$ 15 times the limit of 4.3.1 At 125 °C (with $U_{\rm C}$ ):
					$\leq$ 8 times the limit of 4.3.1 At 105 °C (with $U_R$ ):
					≤12,5 times the limit of 4.3.1 At 85 °C (with $U_{\rm R}$ ):
					$\leq$ 10 times the limit of 4.3.1
			Capacitance <sup>c</sup>		$\Delta C/C \leq 20$ % of value measured in Step 1
			Tangent of loss angle <sup>c</sup>		≤ limit of 4.3.3
			Non-solid electrolyte capacitors:		
			Step 1: 20 °C		
			Capacitance <sup>c</sup>		For use as reference value
			Tangent of loss angle <sup>c</sup>		
			Impedance (at same frequency as Step 2)		For use as reference value
			Step 2: Lower category temperature		
<sup>a</sup> Sub	clause numbers of te	st and p	erformance requirements ref	er to Clause 4.	
<sup>b</sup> In th	nis table, D = destruc	tive, ND	= non-destructive.		
<sup>c</sup> If ap	oplicable.				

Subclause number and test <sup>a</sup>	D or ND <sup>b</sup>	Conditions of test <sup>a</sup>	Number of specimens (n) and number of permissible nonconforming items (c)	Perforr require	
Group 6 (continued)	D		See Table 1		
4.19 (continued)		Impedance		Ratio with resp value in Step 1	
				Rated voltage V	Ratio of impedance
				$U_{R} \le 6,3$ 6,3< $U_{R} \le 16$ 16< $U_{R} \le 160$ 160< $U_{R}$	≤10 ≤8 ≤6 ≤10
		Step 3: Upper category temperature			
		Leakage current		At 125 °C: $\leq$ 10 limit of 4.3.1 At 105 °C: $\leq$ 8 t of 4.3.1 At 100 °C: $\leq$ 8 t of 4.3.1 At 100 °C: $\leq$ 8 t of 4.3.1 At 85 °C: $\leq$ 5 tir of 4.3.1	imes the limit imes the limit
		Capacitance <sup>c</sup>		See detail spe	cification
		Tangent of loss angle <sup>c</sup>		See detail spe	cification
4.20 Charge and		Temperature: 20 °C			
discharge (if required)		Number of cycles:			
		$U_{\sf R} \le 160 \; \sf V: \; 10^6$			
		U <sub>R</sub> > 160 V: under consideration			
		Duration of charge: 0,5 s			
		Duration of discharge: 0,5 s			
4.20.1 Initial measurement		Capacitance			
4.20.3 Final measurements		Visual examination		No visible dam non-solid elect capacitors no l electrolyte	rolyte
		Capacitance		$\Delta C/C$ for:	
				Solid electrol	<b>yte:</b> ≤5 %
				Non-solid elec ≤10 % of value 4.20.1	
<sup>a</sup> Subclause numbers of t	est and	performance requirements ref	er to Clause 4	•	
<sup>b</sup> In this table, D = destru	ctive, NI	D = non-destructive.			
<sup>c</sup> If applicable.					

# Table 2 (continued)

# 3.5 Quality conformance inspection

#### 3.5.1 Formation of inspection lots

a) Groups A and B inspection

These tests shall be carried out on a lot-by-lot basis.

A manufacturer may aggregate the current production into inspection lots subject to the following safeguards.

- 1) The inspection lot shall consist of structurally similar capacitors (see 3.2).
- 2a) The sample tested shall be representative of the values and dimensions contained in the inspection lot:
  - in relation to their number;
  - with a minimum of five of any one value.
- 2b) If there are less than five of any one value in the sample the basis for the drawing of samples shall be agreed between the manufacturer and the national supervising inspectorate.
- b) Group C inspection

These tests shall be carried out on a periodic basis.

Samples shall be representative of the current production of the specified periods and shall be divided into high-, medium- and low-voltage ratings. In order to cover the range of approvals in any period one case size shall be tested from each voltage group. In subsequent periods, other case sizes and/or voltage ratings in production shall be tested with the aim of covering the whole range.

# 3.5.2 Test schedule

The schedule for the lot-by-lot and periodic tests for quality conformance inspection is given in Table 4 of the blank detail specification, IEC 60384-4-1 or IEC 60384-4-2, as applicable.

# 3.5.3 Delayed delivery

When, according to the procedures of 3.10 of IEC 60384-1, re-inspection has to be made, solderability and capacitance shall be checked as specified in Group A and B inspection.

### 3.5.4 Assessment levels

The assessment level(s) given in the blank detail specification shall preferably be selected from Tables 3 and 4.

Table 3 – Lot-by-lot inspection

Inspection subgroup <sup>a</sup>	DZ <sup>b</sup>		EZ			FZ⁵			GZ⁵			
	IL °	n °	c °	IL °	n °	c °	IL °	n °	c °	IL °	n °	c °
A0					100 % <sup>d</sup>							
A1				S-3	е	0						
A2				S-3	е	0						
B1				S-3	е	0						
B2				S-3	е	0						
<sup>a</sup> The content of	of the insp	bection su	ubgroup i	s describ	ed in Cla	use 2 of	the relev	ant blank	detail s	pecificatio	on.	•
<sup>b</sup> Assessment I	evels DZ,	FZ and	GZ are u	nder cons	sideration	۱.						
<sup>c</sup> <i>IL</i> = inspectio	on level											
<i>n</i> = sample si	ze											
c = permissib	le numbe	r of nonc	onformin	g items								
d 100 % testing conforming it ppm values a items occur in	ems per r any parar	nillion (p netric fai	pm). The llure shal	sampling I be cou	level sh nted as	all be est	tablished	by the m	anufactu	irer. For t	he calcul	ation o
e Number to be	e tested: s	ample si	ze as dire	ectly allot	ted to th	e code le	tter for IL	. in Table	2A of IE	C 60410		

#### DZ <sup>b</sup> FΖ<sup>ь</sup> GZ⁵ Inspection ΕZ subgroup<sup>a</sup> **р** ° n ° n ° **с** ° n ° **с** <sup>с</sup> С<sup>с</sup> р° n ° С° р° р° C1A 6 9 0 C1B 6 18 0 C1 6 27 0 C2 6 9 0 C3 3 21 0 C4A 12 6 0 C4B 12 6 0 C5A 6 12 0 C5B 12 6 0 C6 6 15 0 а The content of the inspection subgroup is described in Clause 2 of the relevant blank detail specification. b Assessment levels DZ, FZ and GZ are under consideration. с p = periodicity in months

# Table 4 – Periodic inspection

n = sample size

c = permissible number of nonconforming items

# 4 Test and measurement procedures

# **4.1 Pre-conditioning** (for non-solid electrolyte capacitors only)

Before starting the test programme, all capacitors shall be pre-conditioned by the application of the rated voltage from a direct voltage source having a low internal resistance, such as a regulated power supply. The voltage shall be applied to the capacitor through a resistor the value of which shall be approximately 100  $\Omega$  for rated voltages up to and including 100 V, and approximately 1 000  $\Omega$  for rated voltages above 100 V.

The voltage shall be maintained for 1 h after its value across the capacitor has become equal to the rated voltage with a tolerance of  $\pm 3$  %. After this pre-conditioning, the capacitors shall be discharged through a resistor of approximately 1  $\Omega$  per applied volt.

The tests in 3.4.2 shall be made after the capacitors have been stored for a period of 12 h to 48 h during which no voltage shall be applied. No further pre-conditioning as described above shall be applied during the test programme.

# 4.2 Visual examination and check of dimensions

See 4.4 of IEC 60384-1.

# 4.3 Electrical tests

# 4.3.1 Leakage current

According to 4.9 of IEC 60384-1, with the following details:

# 4.3.1.1 Measuring conditions

The rated voltage shall be applied across the capacitor and its protective resistor. Unless otherwise stated in the detail specification, the protective resistor shall be approximately 100  $\Omega$  for rated voltages  $\leq$ 100 V and approximately 1 000  $\Omega$  for rated voltages >100 V.

# 4.3.1.2 Requirements

a) For non-solid electrolyte capacitors, the leakage current shall not exceed the values given in Table 5.

CU product	Leakage current μA	
μC	Long-life grade capacitors	General-purpose grade capacitors
≤1 000	0,01 <i>CU</i> or 1 μA (whichever is the greater)	0,05 <i>CU</i> or 5 μA (whichever is the greater)
>1 000	0,006 <i>CU</i> + 4 μA	0,03 <i>CU</i> + 20 μA

# Table 5 – Leakage current requirements

b) For solid electrolyte capacitors, the leakage current shall not exceed:

for long-life grade capacitors:	≤ 0,1 <i>CU</i>
for general-purpose grade capacitors:	≤ 0,15 <i>CU</i>

# 4.3.2 Capacitance

According to 4.7 of IEC 60384-1, with the following details:

# 4.3.2.1 Measuring conditions

Measuring voltage: max. 0,5 V r.m.s. or such lower voltage as is required, in order not to exceed the rated ripple current.

A d.c. bias voltage of 1,1 V to 1,5 V for types with a rated voltage of  $\leq$  2,5 V, 2,1 V to 2,5 V for types with a rated voltage of > 2,5 V may be applied during the measurement.

The frequency of the measuring voltage shall be 100 Hz or 120 Hz.

A different frequency may be applied provided that the measured capacitance is corrected to a value of 100 Hz or 120 Hz. The detail specification shall state the frequency to be applied.

# 4.3.2.2 Requirement

The capacitance shall be within the rated tolerance.

# 4.3.3 Tangent of loss angle (tan $\delta$ ) or equivalent series resistance (ESR)

According to 4.8 of IEC 60384-1, with the following details:

# 4.3.3.1 Measuring conditions

The measurement shall be under the conditions of 4.3.2.1. The inaccuracy of the measuring equipment shall not exceed 0,01 absolute value.

#### 4.3.3.2 Requirements

The limits for tangent of loss angle or for the equivalent series resistance ESR shall be specified in the detail specification.

#### 4.3.4 Impedance

According to 4.10 of IEC 60384-1, with the following details:

#### 4.3.4.1 Initial measurement

The frequency of the measuring voltage shall be chosen from one of the following frequencies: 100 Hz, 120 Hz, 1 kHz, 10 kHz, 100 kHz and 1 MHz, and shall be that at which the lowest value of impedance is likely to occur. The tolerance on all frequencies for measuring purposes shall not exceed  $\pm 20$  %. The value of the measuring frequency shall be prescribed in the detail specification.

# 4.3.4.2 Measuring conditions

The voltage used for the measurement shall be as small as practicable and shall be applied for a time short enough to avoid undue heating of the capacitor.

To demonstrate that the voltage is sufficiently small, it shall be applied to one of the capacitors in each sample for 1 min during which time there shall be no readable change in the impedance of the capacitor.

The error of measurement shall not exceed 5 % of the requirement of 0,02  $\Omega$ , whichever is the greater.

# 4.3.4.3 Measurement at lower category temperature

The frequency shall be 100 Hz or 120 Hz unless otherwise specified in the detail specification.

# 4.3.4.4 Requirements

The impedance shall meet the requirements of the detail specification.

# **4.3.5 Insulation resistance of the external insulation** (if applicable)

According to 4.5 of IEC 60384-1, with the following details.

# 4.3.5.1 Measuring conditions

A metal foil shall be wrapped closely around the full length of the body of the capacitor, protruding by at least 5 mm from each end, provided a distance of not less than 0,5 mm can be maintained between the metal foil and the terminations. The ends of the foil shall not be folded over the ends of the capacitor. If the 0,5 mm distance cannot be maintained, the protrusion of the foil shall be reduced as may be necessary to establish the 0,5 mm distance.

When applicable, the V-block method is permitted as an alternative.

A direct voltage of 100 V  $\pm$  15 V shall be applied between the metal foil or the V-block and the termination connected to the capacitor body for a minimum of 1 min or for the time required to obtain a stable reading. At the end of this period, the insulation resistance shall be measured.

# 4.3.5.2 Requirement

The insulation resistance shall be not less than 100  $\mbox{M}\Omega.$ 

# **4.3.6** Voltage proof of the external insulation (if applicable)

According to 4.6 of IEC 60384-1, with the following details.

# 4.3.6.1 Measuring conditions

A metal foil shall be wrapped closely around the full length of the capacitor, protruding by at least 5 mm from each end, provided a distance of not less than 1 mm can be maintained between the metal foil and the terminations. The ends of the foil shall not be folded over the ends of the capacitor. If the 1 mm distance cannot be maintained, the protrusion of the foil shall be reduced as may be necessary to establish the 1 mm distance.

When applicable, the V-block method is permitted as an alternative.

A direct voltage gradually increasing at a rate of 100 V/s to a maximum of 1 000 V shall be applied between the metal foil or the V-block and the termination connected to the capacitor body.

The voltage of 1 000 V shall be applied for 1 min  $\pm$  5 s.

# 4.3.6.2 Requirement

There shall be no breakdown or flashover during the test.

# 4.4 Robustness of terminations

According to 4.13 of IEC 60384-1, with the following details.

The detail specification shall specify the test method and degree of severity to be used.

Torque for nominal thread diameter of 8 mm:

Severity 1: 5 Nm

Severity 2: 2,5 Nm

# 4.4.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

# 4.5 Resistance to soldering heat

(Not applicable to capacitors with screw terminations or other terminations not designed to be soldered, as stated in the detail specification.)

According to 4.14 of IEC 60384-1, with the following details:

# 4.5.1 Conditions

No pre-drying.

# 4.5.2 Final inspection, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

# 4.6 Solderability

(Not applicable to capacitors with screw terminations or other terminations not designed to be soldered, as stated in the detail specification.)

According to 4.15 of IEC 60384-1, with the following details:

Temperature of the solder bath:

235 °C  $\pm$  5 °C for Sn-Pb solder

245 °C  $\pm$  5 °C for Sn-Ag-Cu solder

250 °C ± 5 °C for Sn-Cu solder

When the solder bath method is not appropriate, the soldering iron shall be used with soldering iron Size A.

When the wetting balance method is appropriate, the detail specification may refer to IEC 60068-2-54.

**4.6.1** The requirement is given in Table 2.

# 4.7 Rapid change of temperature

According to 4.16 of IEC 60384-1, with the following details.

# 4.7.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

# 4.7.2 Conditioning

The capacitors shall be subjected to test Na for 5 cycles. The duration  $t_1$  of the exposure at each temperature limit shall be 30 min or 3 h as specified in the detail specification. The recovery period shall be 16 h.

# 4.7.3 Final inspection, measurements and requirements

After recovery, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

# 4.8 Vibration

According to 4.17 of IEC 60384-1, with the following details:

**4.8.1** Test Fc shall be applied with one of the following severities as prescribed by the detail specification.

Frequency	Amplitude or acceleration (whichever is the lower	Duration
Hz	acceleration)	h
10-55	0,35 mm or 50 m/s <sup>2</sup>	3 × 0,5
10-55	0,75 mm or 100 m/s <sup>2</sup>	3 × 2
10-500	0,75 mm or 100 m/s <sup>2</sup>	3 × 2
10-2 000	0,75 mm or 100 m/s <sup>2</sup>	3 × 2

Table 6 – Amplitude and acceleration options

The detail specification shall specify the frequency range and shall also prescribe the mounting method to be used. For capacitors with axial leads and intended to be mounted by the leads only, the distance between the body and the mounting point shall be 6 mm  $\pm$  1 mm.

#### 4.8.2 Final inspection, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

#### 4.9 Bump

According to 4.18 of IEC 60384-1, with the following details:

The detail specification shall state whether the bump or the shock test applies.

**4.9.1** Total number of bumps:1 000 for general-purpose grade capacitors4 000 for long-life grade capacitors

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Acceleration:	400 m/s <sup>2</sup> (or 40 <i>g</i> )
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Duration of pulse: 6 ms

The detail specification shall also prescribe the mounting method to be used. For capacitors with axial leads and intended to be mounted by the leads only, the distance between the body and the mounting point shall be 6 mm  $\pm$  1 mm.

# 4.9.2 Final examination, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

# 4.10 Shock

According to 4.19 of IEC 60384-1, with the following details.

The detail specification shall state whether the shock or the bump test applies.

**4.10.1** The detail specification shall state which of the following preferred severities, as listed in Table 7, applies.

Pulse shape: half-sine.

Peak acceleration	Corresponding duration of the pulse
g	ms
300	18
500	11
1 000	6

Table 7 – Preferred severities

The detail specification shall also prescribe the mounting method to be used. For capacitors with axial leads and intended to be mounted by the leads only, the distance between the body and the mounting point shall be 6 mm  $\pm$  1 mm.

# 4.10.2 Final inspection, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

# 4.11 Climatic sequence

According to 4.21 of IEC 60384-1, with the following details:

# 4.11.1 Dry heat

According to 4.21.2 of IEC 60384-1.

# 4.11.2 Damp heat, cyclic, Test Db, first cycle

According to 4.21.3 of IEC 60384-1.

# 4.11.3 Cold

According to 4.21.4 of IEC 60384-1.

# 4.11.4 Low air pressure

According to 4.21.5 of IEC 60384-1, with the following details:

**4.11.4.1** The test, if required in the detail specification, shall be made at a temperature of 15  $^{\circ}$ C to 35  $^{\circ}$ C and an air pressure of 8 kPa. The duration of the test shall be 5 min.

**4.11.4.2** While still at the specified low pressure and during the last minute of the five-minute period, the rated voltage  $U_R$  shall be applied.

# 4.11.4.3 Requirements

During and after the test, the capacitor shall meet the requirements given in Table 2.

# 4.11.5 Damp heat, cyclic, Test Db, remaining cycles

According to 4.21.6 of IEC 60384-1.

**4.11.6 Sealing** (if required by the detail specification)

According to 4.20 of IEC 60384-1, with the following details.

The Test Qc of IEC 60068-2-17 shall be applied at the end of the climatic sequence.

4.11.6.1 The detail specification shall prescribe whether Method 1 or Method 2 applies.

# 4.11.6.2 Recovery

If the capacitors have been immersed in a liquid, they shall be shaken to remove excess liquid, and then remain under standard atmospheric conditions for testing for 1 h to 2 h.

#### 4.11.7 Final inspection, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

#### 4.12 Damp heat, steady state

According to 4.22 of IEC 60384-1, with the following details:

#### 4.12.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

#### 4.12.2 Final inspection, measurements and requirements

After recovery, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

#### 4.13 Endurance

According to 4.23 of IEC 60384-1, with the following details.

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#### 4.13.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

**4.13.2** Duration: shall be specified in the detail specification selected from the following: Long-life grade: 2 000 h; 3 000 h; 5 000 h; 7 000 h or 10 000 h General-purpose grade: 1 000h or 2 000 h

Ambient temperature: upper category temperature.

Applied voltage: category voltage, unless otherwise specified in the detail specification.

NOTE When the category voltage is different from the rated voltage, the sample tested is divided into two parts and submitted to the rated and category voltages and temperatures respectively.

When specified in the detail specification a sinusoidal alternating voltage with frequency of 50 Hz, 60 Hz, 100 Hz or 120 Hz, as specified, shall be superimposed on the d.c. voltage so that the peak voltage does not exceed the value of the rated direct voltage and that the rated ripple current is not exceeded.

- a) For solid electrolyte capacitors, the impedance of the voltage source shall be maximum 3  $\Omega.$
- b) For non-solid electrolyte capacitors, the direct voltage shall be supplied by a regulated power supply having a low internal resistance and shall be applied to each capacitor or capacitor section through a separate resistor. The value of this resistor shall be so chosen that a short circuit of one of the capacitors or capacitor sections will have no influence on the rest of the sample, but the resistance value shall not exceed 1 000  $\Omega$ .

#### 4.13.3 Final inspection, measurements and requirements

After recovery, for a minimum of 16 h, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

NOTE When the detail specification indicates that a repetitive pressure relief device is applied at the capacitor, the effects of the intended operation of the pressure relief device (for example, slight colouring or discolouring, slight wetting, etc.) should not be considered as leakage and/or visual damage. Seepage, however, is not permitted.

#### 4.14 Surge

According to 4.26 of IEC 60384-1, with the following details:

#### 4.14.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

#### 4.14.2 Test procedure

The capacitors shall be submitted to 1 000 cycles, each consisting of charge as described below, followed by a no-load period of 5 min 30 s with the capacitor disconnected and allowed to discharge internally.

The test temperature shall be upper category temperature for long-life grade capacitors and room temperature for general-purpose grade capacitors.

Charge

Applied voltage:	1,15 times the rated or category voltage for rated voltages $\leq$ 315 V	
	1,10 times the rated or category voltage for rated voltages > 315 V	See 2.2.7

Internal resistance of the voltage source: as required for RC = 0,1 s  $\ \pm \$  0,05 s

Duration: 30 s

#### 4.14.3 Final inspection, measurements and requirements

After recovery, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

NOTE When the detail specification indicates that a repetitive pressure relief device is applied at the capacitor, the effects of the intended operation of the pressure relief device (for example, slight colouring or discolouring, slight wetting, etc.) should not be considered as leakage and/or visual damage. Seepage, however, is not permitted.

**4.15 Reverse voltage** (if required by the detail specification)

#### 4.15.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

**4.15.2** The capacitors shall be subjected to the conditions under a) followed by the conditions under b).

a)	Test temperature:	Upper category temperature.
	Applied voltage:	1) For solid electrolyte capacitors, a direct voltage 0,15 times the category voltage shall be applied in the reverse voltage polarity direction.
		2) For non-solid electrolyte capacitors, a voltage of 1 V d.c., unless otherwise specified in the detail specification.
	Duration:	125 h.
b)	Test temperature:	Upper category temperature.
	Applied voltage:	Direct voltage equal to the category voltage in the forward polarity direction.
	Duration:	125 h.

#### 4.15.3 Final inspection, measurements and requirements

After recovery the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

#### **4.16 Pressure relief** (if required by the detail specification)

Unless otherwise specified in the detail specification, one of the tests, as described in 4.28 of IEC 60384-1, shall be applied:

# 4.16.1 Requirement

The pressure relief device shall open in such a way as to avoid any danger of explosion or fire.

# 4.17 Storage at high temperature

According to 4.25 of IEC 60384-1, with the following details:

#### 4.17.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

**4.17.2** Temperature:Upper category temperature.Duration:96 h  $\pm$  4 h.

# 4.17.3 Final measurements and requirements

After recovery, for a minimum of 16 h, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

#### 4.18 Storage at low temperature (for non-solid electrolyte capacitors only)

According to 4.25 of IEC 60384-1, with the following details:

# 4.18.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

# 4.18.2 Final inspection, measurements and requirements

After recovery, for a minimum of 16 h, the capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

# 4.19 Characteristics at high and low temperature

According to 4.29 of IEC 60384-1, with the following details:

#### 4.19.1 Measurements and requirements

The capacitors shall be measured and shall meet the requirements given in Table 2.

#### **4.20** Charge and discharge (if required by the detail specification)

According to 4.27 of IEC 60384-1, with the following details:

#### 4.20.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

**4.20.2** At an ambient temperature of 20 °C, the capacitors shall be subjected to the specified number of cycles, each cycle consisting of a charge according to a) followed by a discharge according to b).

In cases where an increase of the cycling period is required, leaving the charging time unchanged in order not to exceed the maximum permissible heat generated in the capacitor, this shall be stated in the detail specification.

Applied voltage:	rated direct voltage.
Internal resistance of the voltage source plus external series resistor:	as required for $RC = 0,1 s$
Duration:	0,5 s.

b) Discharge

······································	
No voltage applied.	
Discharge resistor:	as required for RC = 0,1 s
Duration:	0,5 s
Number of cycles:	
For capacitors with rated voltage $U_{R} \leq$ 160 V:	10 <sup>6</sup>
For capacitors with rated voltage $U_R$ > 160 V:	under consideration.

# 4.20.3 Final inspection, measurements and requirements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

**4.21 High surge current** (for solid electrolyte capacitors only and if required by the detail specification)

According to 4.39 of IEC 60384-1, with the following details.

# 4.21.1 Initial measurements

Not required.

# 4.21.2 Final measurements and requirements

Final measurements and requirements are those for the subsequent tests in Group 0 or in the blank detail specification in Group A, as appropriate.

# 4.22 Voltage transient overload

According to 4.40 of IEC 60384-1, with the following details:

# 4.22.1 Initial measurement

The capacitance shall be measured according to 4.3.2.

# 4.22.2 Final measurements

The capacitors shall be visually examined and measured and shall meet the requirements given in Table 2.

The items described in 4.40.4 shall be specified in the detail specification.

In 4.40.5, capacitance, leakage current, tangent of loss angle and the other parameters required by the relevant specification.



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